

INTERNATIONAL STANDARD

**Radio-frequency connectors –
Part 39: Sectional specification for CQM series quick lock RF connectors**





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IEC 61169-39

Edition 1.0 2009-06

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INTERNATIONAL
ELECTROTECHNICAL
COMMISSION

PRICE CODE

U

ICS 33.120.30

ISBN 2-8318-1047-3

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

RADIO-FREQUENCY CONNECTORS –

Part 39: Sectional specification for CQM series quick lock RF connectors

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International Standard IEC 61169-39 has been prepared by subcommittee 46F: RF and microwave passive components, of IEC technical committee 46: Cables, wires, waveguides, R.F. connectors, R.F. and microwave passive components and accessories.

The text of this standard is based on the following documents:

CDV	Report on voting
46F/107/CDV	46F/133/RVC

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

The committee has decided that the contents of this publication will remain unchanged until the maintenance result date indicated on the IEC web site under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

A list of all parts of the IEC 61169 series can be found, under the general title *Radio-frequency connectors*, on the IEC website.

A bilingual version of this publication may be issued at a later date.

RADIO-FREQUENCY CONNECTORS –

Part 39: Sectional specification for CQM series quick lock RF connectors

1 Scope

CQM series quick lock connectors with characteristic impedance 50 Ω are used for high power microwave applications, connecting with RF cables or microstrips. The operating frequency limit is at least 4 GHz.

This sectional specification provides information and rules for the preparation of detail specifications for CQM series quick lock RF connectors together with the pro forma blank detail specification (DS).

It also prescribes mating interface dimensions for general purpose connectors, dimensional details of standard test connectors grade 0, gauging information and tests selected from IEC 61169-1, applicable to all detail specifications relating to CQM series connectors.

This specification indicates the recommended performance characteristics to be considered when writing a detail specification and it covers test schedules and inspection requirements for assessment levels M and H.

2 Normative references

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 61169-1:1992, *Radio-frequency connectors – Part 1: Generic specification – General requirements and measuring methods*

3 Mating interface and gauge information

All undimensioned pictorial configurations are for reference purposes only.

3.1 Dimensions-General connectors – Grade 2

3.1.1 Connector with pin-centre contact

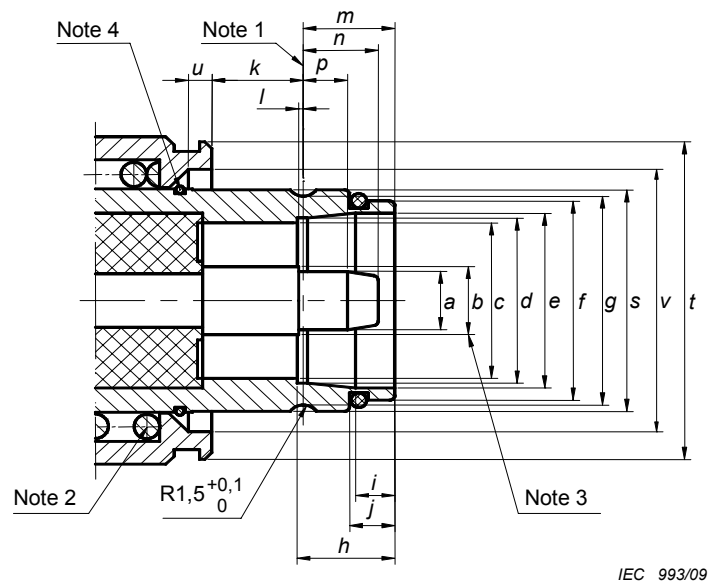


Figure 1 – Connector with pin-centre contact (for dimensions, see Table 1)

Table 1 – Dimensions of connector with pin-centre contact

Reference	mm		Note
	min	max	
<i>a</i>	5,96	6,04	Diameter
<i>b</i>	7(nominal)		Diameter
<i>c</i>	15,85	16,25	Diameter
<i>d</i>	16,90	17,10	Diameter
<i>e</i>	18,00	18,20	Diameter
<i>f</i>	21,00	21,20	Diameter
<i>g</i>	21,90	22,10	Diameter
<i>h</i>	8,90	9,20	
<i>i</i>	3,70	3,90	
<i>j</i>	4,30	4,50	
<i>k</i>	-	9,80	
<i>l</i>	0,30	0,50	
<i>m</i>	8,80	9,00	
<i>n</i>	7,20	7,40	
<i>p</i>	4,20	4,40	
<i>s</i>	23,20	23,30	Diameter
<i>t</i>	35,00	35,20	Diameter
<i>u</i>	2,10	2,30	
<i>v</i>	26,9	27,2	Diameter

NOTE 1 Mechanical reference plane.

NOTE 2 The spring force is 50 N to 60 N max.

NOTE 3 Tolerances of dimensions are to meet the requirements of characteristic impedances.

NOTE 4 Ring.

3.1.2 Connectors with socket-centre contact

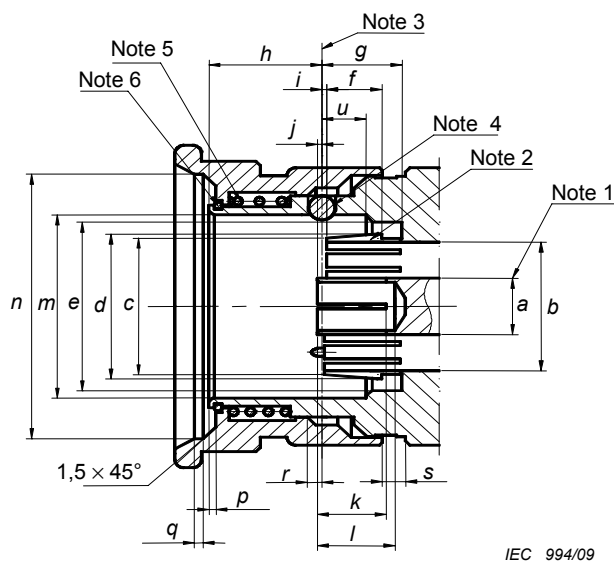


Figure 2 – Connector with socket-centre contact (for dimensions, see Table 2)

Table 2 – Dimensions of connector with socket-centre contact

Reference	mm		Note
	min	max	
a	7 (nominal)		Diameter (Note 1)
b	15,85	16,25	Diameter
c	16,70	16,90	Diameter
d	17,80	18,00	Diameter
e	22,10	22,30	Diameter
f	6,30	6,50	
g	9,10	9,30	
h	12,75	12,85	
i	0,20	0,40	
j	--	0,20	
k	7,00	7,50	
l	8,50	9,00	
m	23,60	23,80	Diameter
n	35,20	35,40	Diameter
p	0,80	1,00	
q	1,10	1,30	
r	1,60	--	
s	2,60	--	
u	4,90	5,20	

NOTE 1 Design for slotting optional, closed contacts should meet electrical and mechanical requirements.
 NOTE 2 Design for slotting optional, flared contacts $\varnothing d$ should be flared to $\varnothing 18,4 \sim \varnothing 18,5$.
 NOTE 3 Mechanical reference plane.
 NOTE 4 Three steel balls, $\varnothing 3$.
 NOTE 5 The spring force is 2 N to 6 N, movement is 1,60 mm min.
 NOTE 6 Ring.

3.2 Gauges

3.2.1 Connectors with socket-centre contact

3.2.1.1 Gauge for outer contact of socket connector

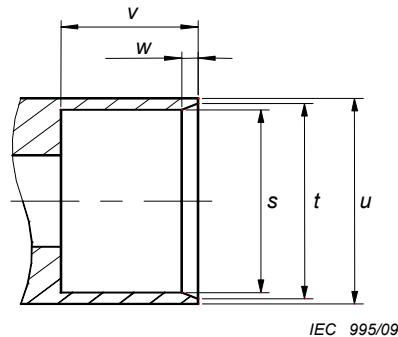


Figure 3 – Gauge for outer contact of socket connector (for dimensions, see Table 3)

Table 3 – Dimensions of gauge for outer contact of socket connector

Gauge A (for sizing purposes)			Gauge B (for measurement of gauge retention force for outer conductor) Mass (weight) of gauge: 200 g ± 5 g		Note
Ref.	mm		mm		
	min	max	min	max	
s	18,05	18,10	18,15	18,18	
t	18,70	18,80	18,70	18,80	
u	20,00	20,80	20,00	20,80	
v	9,50	9,60	9,40	9,50	
w	1,30	1,50	1,30	1,50	

NOTE Material: steel, polished, surface roughness: $R_a \leq 0,4 \mu\text{m}$.

3.2.1.2 Test sequence

Gauge A shall be placed over the outer contact of the connector once. This is a sizing operation. After this, gauge B shall be placed over the outer contact in a vertical position. The gauge shall be retained.

3.2.1.3 Gauge pin for socket-centre contact

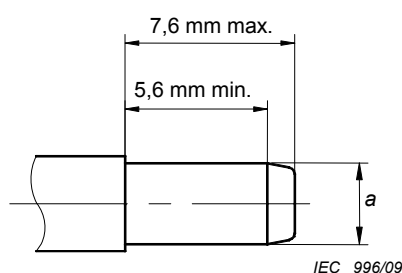


Figure 4 – Gauge pin for socket contact (for dimensions, see Table 4)

Table 4 – Dimensions of gauge pin for socket contact

Gauge C (for sizing purposes)			Gauge D (for measurement of gauge retention force for centre contact) Mass (weight) of gauge: 600 g ± 5 g	
Ref.	mm		mm	
	min	max	min	max
<i>a</i>	6,05	6,10	5,95	6,00
NOTE Material: steel, polished, surface roughness: Ra ≤ 0,4 μm.				

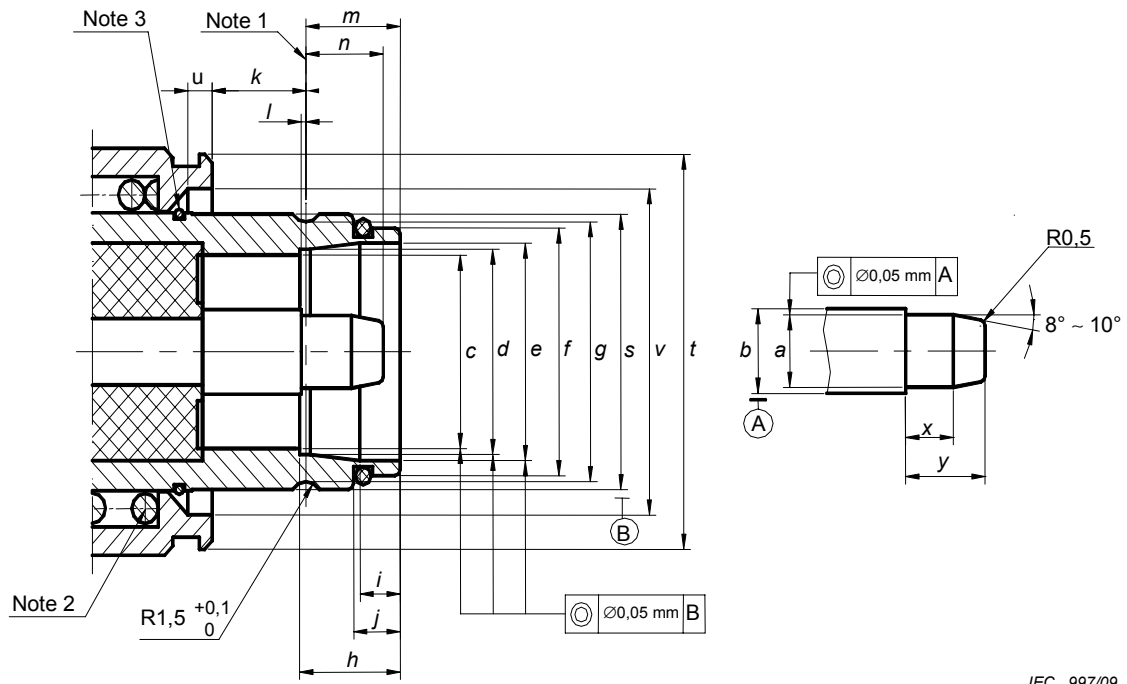
3.2.1.4 Test sequence

Test pin gauge C shall be inserted into the centre contact three times with a minimum depth of 5,6 mm. This is a sizing operation and should only be carried out when the socket centre contact is removed from the connector.

After this, gauge D shall be inserted and held in the vertical position. The gauge shall be retained. This test can also be carried out on connector when the socket centre contact is not removed once the sizing operation has been carried out on the contact whilst it was removed from the connector.

3.3 Dimensions – standard test connectors – Grade 0

3.3.1 Connector with pin-centre contact



IEC 997/09

Figure 5 – Connector of pin-centre contact (for dimensions, see Table 5)

Table 5 – Dimensions of connector with pin-centre contact

Reference	mm		Note
	min	max	
<i>a</i>	5,99	6,00	Diameter
<i>b</i>	6,97	6,98	Diameter
<i>c</i>	16,05	16,07	Diameter
<i>d</i>	16,96	17,04	Diameter
<i>e</i>	18,05	18,15	Diameter
<i>f</i>	21,05	21,15	Diameter
<i>g</i>	21,95	22,05	Diameter
<i>h</i>	9,02	9,08	
<i>i</i>	3,77	3,83	
<i>j</i>	4,35	4,45	
<i>k</i>	9,70	9,80	
<i>l</i>	0,30	0,50	
<i>m</i>	8,86	8,94	
<i>n</i>	7,27	7,33	
<i>s</i>	22,20	22,25	Diameter
<i>t</i>	23,04	23,10	Diameter
<i>u</i>	2,15	2,25	
<i>v</i>	27,00	27,10	Diameter
<i>x</i>	4,20	4,40	
<i>y</i>	7,20	7,40	

NOTE 1 Mechanical reference plane.
 NOTE 2 The spring force is 50 N to 60 N.
 NOTE 3 Ring.

3.3.2 Connector with socket-centre contact

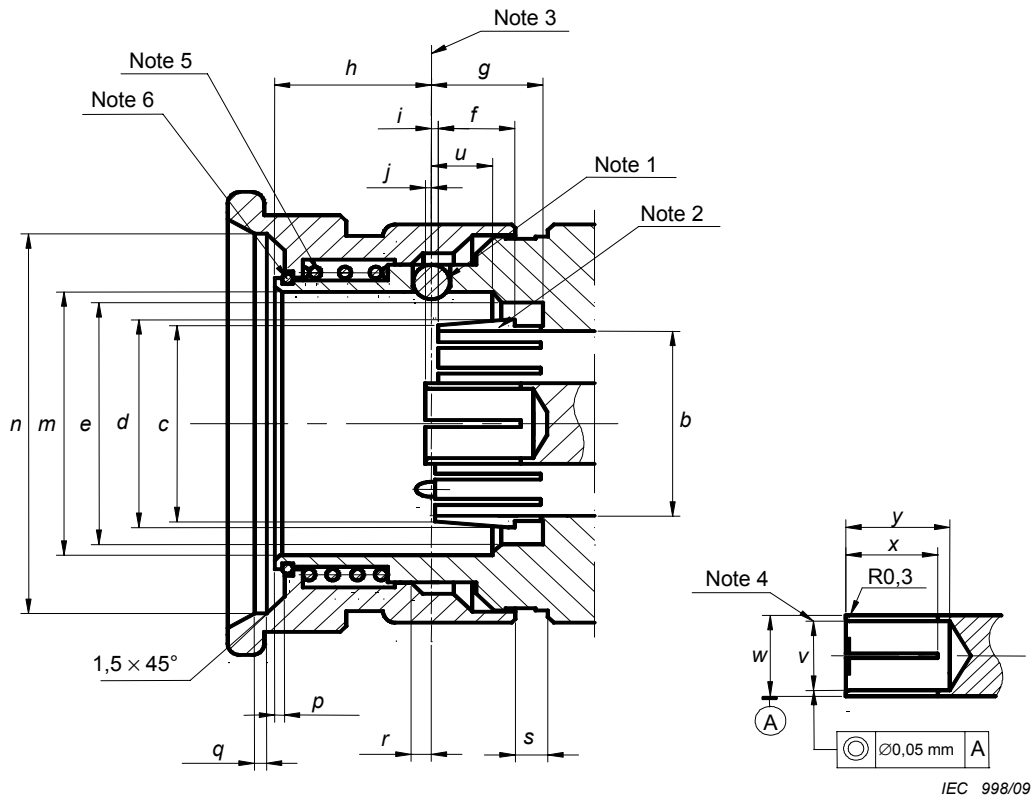


Figure 6 – Standard test connector with socket-centre contact
(for dimensions, see Table 6)

Table 6 – Dimensions of standard test connector with socket-centre contact

Reference	mm		Note
	min	max	
<i>b</i>	16,05	16,07	Diameter
<i>c</i>	16,92	16,96	Diameter
<i>d</i>	18,01	18,05	
<i>e</i>	22,18	22,25	Diameter
<i>f</i>	6,35	6,42	
<i>g</i>	9,18	9,25	
<i>h</i>	12,78	12,81	
<i>i</i>	0,28	0,32	
<i>j</i>	-	0,20	
<i>m</i>	23,68	23,75	Diameter
<i>n</i>	35,25	35,35	Diameter
<i>p</i>	0,88	0,96	
<i>q</i>	1,06	1,14	
<i>r</i>	1,60	-	
<i>s</i>	2,60	-	
<i>u</i>	4,95	5,05	
<i>v</i>			See Note 4
<i>w</i>	6,97	7,00	Diameter
<i>x</i>	7,00	7,20	
<i>y</i>	8,50	9,00	

NOTE 1 Three steel balls, Ø3.
 NOTE 2 Design for slotting optional, flared contacts Ø*d* should be flared to Ø 18,40~Ø 18,50.
 NOTE 3 Mechanical reference plane.
 NOTE 4 When a gauge pin with diameter of 5,99 mm min 6 mm max is inserted into a depth of 5,00 mm min, dimension *v* should meet the requirements of dimension *w*.
 NOTE 5 The spring force is 2 N to 6 N, movement is 1,60 mm min.
 NOTE 6 Ring.

4 Quality assessment procedure

4.1 General

The following clauses provide recommended rating, performance and test conditions to be considered when writing a detail specification (DS). They also provide an appropriate schedule of tests with minimum levels of conformance inspection sampling, together with the pro forma blank detail specification (BDS) and instructions for the preparation of a detail specification.

4.2 Rating and characteristics (see Clause 6 of IEC 61169-1)

The values indicated below (see Table 7) are recommended for CQM series quick lock connectors and are given for the writer of the detail specification. They are applicable for the condition when the connectors are fully mated.

Certain tests are listed without any recommended values being given. These tests will usually not be required. When these tests are required, appropriate values shall be entered in the detail specification at the discretion of the specification writer.

Table 7 – Ratings and characteristics

Ratings and characteristics	IEC 61169-1 Subclause	Value	Remarks including any deviations from standard test methods
<i>Electrical</i>			
Nominal impedance		50 Ω	
Frequency range – Grade 2 connectors		Up to 4 GHz	Or upper frequency limit of the cable
Reflection factor	9.2.14		
– straight styles ^a		$7 \leq 0,1 \%$	
– right angle styles		As specified in the DS	
– component mounting styles		As specified in the DS	
– solder bucket and PCB mounting styles		As specified in the DS	
Centre contact resistance	9.2.3		
– initial		$\leq 3 \text{ m}\Omega$	
– after conditioning		$\leq 5 \text{ m}\Omega$	
Outer conductor continuity ^a	9.2.3		
– initial		$\leq 3 \text{ m}\Omega$	
– after conditioning		$\leq 5 \text{ m}\Omega$	
Insulation resistance ^a	9.2.5		
– initial		$\geq 5 \text{ G}\Omega$	
– after conditioning		$\geq 500 \text{ M}\Omega$	
Proof voltage at sea level ^{b c}	9.2.6	2 700 V	(86~106 kPa)
Proof voltage at 4,4 kPa ^{b c}	9.2.6	350 V	4,4 kPa approximately equivalent to 20 km
Environmental test voltage at sea level ^{c d}	9.2.6, 9.4.6, 9.3	2 000 V	(86~106 kPa)
Screening effectiveness ^g	9.2.8	90 dB to 1 GHz	$Z_t \leq 0,02 \text{ m}\Omega$ applied torque 25 Nm
Discharge test (Corona) – at sea level (cable 60096 IEC 50-3)	9.2.9	$\geq 1 \text{ 000 V}$	Extinction voltage

Ratings and characteristics	IEC 61169-1 Subclause	Value	Remarks including any deviations from standard test methods
<i>Mechanical</i>			
Centre contact captivation – axial force – torque	9.3.5	15 N, 1 min N/A ^f	Maximum displacement 0,25 mm each direction
Engagement and separation force	9.3.6		
– engagement force		≤ 150 N	
– separation force		>10 N & <22 N	
Gauge retention force (resilient contacts) – centre – outer	9.3.4	>6 N >2 N	
Mechanical tests on cable fixing	9.3.7		
Cable pulling	9.3.8	See DS	
cable rotation (nutating)	9.3.7.2	See DS	
Cable bending	9.3.9	See DS	
Cable torsion	9.3.10	See DS	
Tensile strength of coupling mechanism	9.3.11	150 N	
Bending moment (and sharing force)	9.3.12	N/A	
Vibration	9.3.3	100 m/s ² 10 Hz – 500 Hz	10 g _n acceleration
Bump	9.3.13	–	
Shock	9.3.14	750 m/s ² ½ sin 6 ms	75 g _n acceleration
<i>Environmental</i>			
Climatic category ^e		55/155/56	
Sealing – non-hermetic	9.4.5.1	1 cm ³ /h max. 100 kPa – 110 kPa differential	
Salt mist	9.4.6	Duration of spraying: 48 h	
<i>Endurance</i>			
Mechanical	0,19.57.10	5 000 operations	
High temperature ^e	0 9.6.3	1 000 h at 155 °C	
<p>^a These values apply to basic connectors. They depend on the cable used. Relevant values are given in the DS.</p> <p>^b Value for a single pair of mated connector</p> <p>^c Voltage values are r.m.s. values at 40 Hz to 60 Hz, unless otherwise specified.</p> <p>^d Cables used with these connectors may have values of lower performance than those given in this table.</p> <p>^e For certain connectors the upper temperature limit is restricted by the cable characteristics. Reference should be made to the relevant cable specification.</p> <p>^f N/A= Not applicable.</p> <p>^g When interfaces are fully mated.</p>			

4.3 Test schedule and inspection requirements

4.3.1 Acceptance tests

Table 8 – Acceptance tests

	Test method IEC 61169-1 Subclause	Assessment level M (higher)				Assessment level H (lower)			
		Test required	IL	AQL %	Period	Test required	IL	AQL %	Period
<i>Group A1</i>									
Visual examination	9.1.2	a	II	1,0		a	S3	1,5	
<i>Group B1</i>									
Outline dimensions	9.1.3.1	a	S4	0,4		a	S3	4,0	
Mechanical compatibility	9.1.3.3	a	II	1,0		a	S3	1,5	
Engagement and separation	9.3.6	a	S4	0,40	Lot	a	S3	1,5	lot
Gauge retention (resilient contact)	9.3.4	ia	II	1,0		ia	S3	1,5	
Sealing, non-hermetic	9.4.5.1	ia	II	0,65	by	ia	S3	1,0	by
Sealing, hermetic	9.4.5.2	ia	II	0,015		ia	S3	0,025	
Voltage proof	9.2.6	a	S4	0,40	lot	a	II	4,0	lot
Solderability piece parts	9.3.2.1.1	ia	S4	0,40		ia	S3	4,0	
Insulation resistance	9.2.5	a	S4	0,40		a	S3	4,0	

4.3.2 Periodic tests

There are no group C tests for levels H and M.

Table 9 – Periodic tests

	Test method IEC 61169-1 subclause	Assessment level M (higher)				Assessment level H (lower)			
		Test required	Number of specimens	Permitted failures per group#	Period	Test required	Number of specimens	Permitted failures per group#	Period
<i>Group D1 (d)</i>			6	1	3 years		3	1	3 years
Solderability connector assemblies	9.3.2.1.1	ia				ia			
Resistance to soldering heat	9.3.2.1.2	ia				ia			
Mechanical tests on cable fixing									
- cable rotation (nutation)	9.3.7.2	na				na			
- cable pulling	9.3.8	ia				ia			
- cable bending	9.3.9	ia				ia			
- cable torsion	9.3.10	ia				ia			
<i>Group D2 (d)</i>			6	1	3 years		3	1	3 years
Contact resistance, outer conductor and screen continuity centre conductor continuity	9.2.3	a				a			
Vibration	9.3.3	a							
Damp heat, steady state	9.4.3	a				a			
<i>Group D3 (d)</i>			1*	1	3 years		1*	1	3 years
Dimensions piece-parts and materials	9.1.3.2	a				a			
<i>Group D4 (d)</i>			6	1	3 years		3	1	3 years
Mechanical endurance	9.5	a				a			
High temperature endurance	9.6	a				a			
Sulphur dioxide	9.4.8	na				na			
<i>Group D5 (d)</i>			6	1	3 years		3	1	3 years
Reflection factor	9.2.1	a				a			

	Test method IEC 61169-1 subclause	Assessment level M (higher)				Assessment level H (lower)			
		Test required	Number of specimens	Permitted failures per group#	Period	Test required	Number of specimens	Permitted failures per group#	Period
Screening effectiveness	9.2.8	a				a			
Water immersion	9.2.7	ia				ia			
Group D6 (d)			6	1	3 years		3	1	3 years
Contact captivation	9.3.5	a				a			
Rapid change of temperature	9.4.4	na				na			
Climatic sequence	9.4.2	a				a			
Group D7 (d)			1§		3 years		1§		3 years
Resistance to solvents and contaminating fluids	9.7	ia				ia			
<p><i>Details of symbols, abbreviations and procedures:</i></p> <p>a = suggested as applicable</p> <p>ia = test suggested (if technically applicable)</p> <p>na = not applicable</p> <p>* = one set of piece-parts each style and variant, unless using common piece parts</p> <p># = for qualification approval (QA) a total of two failures only permitted for level H and 1 failure only for level M from groups D1 to D7</p> <p>§ = Group D7 – number of pairs for each solvent</p> <p>(d) = destructive tests – specimens shall not be returned to stock</p>									

4.4 Procedures

4.4.1 Quality conformance inspection

This shall consist of test groups A1 and B1 on a lot-by-lot basis.

4.4.2 Qualification approval and its maintenance

This shall consist of three consecutive lots passing test groups A1 and B1 followed by selection of specimens from the lots as appropriate. These specimens shall successfully pass the specified periodic D tests.

5 Instructions for preparation of detail specifications

5.1 General

Detail specifications (DS) writers shall use the appropriate BDS pro-forma. The following pages comprise the pro-forma BDS dedicated for use with type CQM connectors. As such, it will already have entered on it information relating to

- a) the basic specification number applicable to all the detail specifications covering connector styles of the type covered by the sectional specification;
- b) the connector series designation.

The specification writer should enter the details relating to the connector style/variant(s) to be covered as indicated. The numbers in brackets on the BDS pro-forma correspond to the following indications which shall be given.

5.2 Identification of the detail specification

- (1) The name of the national standards organization (NSO) under whose authority the DS is published and, if applicable, the organization from whom the DS is available.
- (2) The relevant mark of conformity and the number allotted to the DS by the relevant national or international organization authorizing the DS.
- (3) The number and issue number of the IEC generic or sectional specification as relevant; also national reference if different.
- (4) If different from the IEC number, any national number of the DS, date of issue and any further information required by the national system, together with any amendment numbers.

5.3 Identification of the component

- (5) Enter the following details:

Style: The style designation of the connector including type of fixing and sealing, if applicable.

Attachment: By deletion of the inapplicable options of cable/wire: given for centre and outer conductors.

Special features and markings: As applicable.

- (6) Enter details of assessment level and the climatic category.
- (7) A reproduction of the outline drawing and details of the panel piercing, if applicable. It shall provide the maximum envelope dimensions, also the position of the reference plane and, in the case of a fixed connector, the position of the mounting plane(s) relative to the front face of the connector.
Any maximum panel thickness limitations for fixed connectors shall be stated.
- (8) Particulars of all variants covered by the DS. As appropriate, the information shall include:
 - cable types (or sizes) applicable to each variant;
 - alternative plated or protective finishes;
 - details of alternative mounting flanges having either tapped or plain mounting holes;
 - details of alternative solder spills or solder buckets including, when applicable, those for use with microwave integrated circuit (MIC) components.

5.4 Performance

- (9) Performance data listing the most important characteristics of the connector taking into account the recommended values of 4.2 in this specification. Deviations from the minimum requirements shall be clearly indicated. Non-applicable parameters shall be marked 'na'.

5.5 Marking, ordering information and related matters

- (10) Insert marking and ordering information as appropriate, together with details of related documents and any invoked structural similarity.

5.6 Selection of tests, test conditions and severities

- (11) 'na' shall be used to indicate non-applicable tests. All tests marked 'a' by the detail specification writer shall be mandatory.

(9) Performance (including limiting conditions of use)

Ratings and characteristics	IEC 61169-1 subclause	Value	Remarks including any deviations from standard test methods (11)
<i>Electrical</i>			
Nominal impedance	Ω	
Frequency range		...4 GHz	Measurement frequency range
Reflection factor	9.2.1		
Variant No. Designation 01.....
Centre contact resistance	9.2.3	≤mΩ ≤mΩ	Initial After conditioning
Centre conductor continuity	9.2.3mΩmΩmΩmΩ	Resistance change due to conditioning
Outer contact continuity	9.2.3	≤mΩ ≤mΩ	Initial After conditioning
Insulation resistance	9.2.5	≥GΩ ≥GΩ	Initial After conditioning
+ Proof voltage at sea level	9.2.6kVkVkVkV	86 kPa to 106 kPa
+ Proof voltage at 4,4 kPa	9.2.6VVVVkPa (if not 4,4 kPa)
Environmental test voltage at sea level	9.4.6V	(86 kPa to 106 kPa)
Screening effectiveness	9.2.8dB at....GHz	Z _t ≤ mΩ
Discharge test (corona) at sea level	9.2.9	≥ V ≥ V ≥ V ≥ V	Extinction voltage
ADDITIONAL ELECTRICAL CHARACTERISTICS			
+ Voltage values are r.m.s. values at 50 Hz to 60 Hz, unless otherwise specified.			

Ratings and characteristics	IEC 61169-1 subclause	Value	Remarks including any deviations from standard test methods
<i>Mechanical</i>			
Soldering - bit size	9.3.2.1.1	
Gauge retention resilient contacts - inner contact - outer contact	3.1.2NN	For gauging details, see Figure 4 and Table 4, Figure 3 and Table 3 of IEC 61169-1
Centre contact captivation - axial force - permitted displacement each direction - torque	9.3.5NmmNm	
Engagement and separation - engagement force - separation force	9.3.6NN	
Strength of coupling mechanism	9.3.11N	
Effectiveness of cable fixing against - cable rotation 01.....	9.3.7	Rotations	Bend radius and number of revolutions
- cable pulling 01.....	9.3.8N	Point of application and duration
- cable bending 01.....	9.3.9Cycles	Length of cable mass
- cable torsion 01.....	9.3.10Nm	Duration of applied torque
Bending moment	9.3.12Nm	Relative to reference plane
Bumps total	9.3.13m/s ²to..... Hz	(.....g _n acceleration)
Vibration	9.3.3m/s ²to..... Hz	(.....g _n acceleration)
Shock	9.3.14m/s ²Shapems	(.....g _n acceleration)
ADDITIONAL MECHANICAL CHARACTERISTICS			

Ratings and characteristics	IEC 61169-1 subclause	Value	Remarks including any deviations from standard test methods
<p><i>Environmental</i></p> <p>Climatic category</p> <p>Sealing non-hermetically sealed connectors</p> <p>Sealing hermetically sealed connectors</p> <p>Water immersion</p> <p>Salt mist</p> <p>ADDITIONAL ENVIRONMENTAL CHARACTERISTICS</p>	<p></p> <p>9.4.5.1</p> <p>9.4.5.2</p> <p>9.2.7</p> <p>9.4.6</p>	<p>...../...../.....</p> <p>.....cm³/h</p> <p>10⁻⁵ bar/cm³/h</p> <p>..... h</p>	<p></p> <p>100 kPa to 110 kPa pressure differential</p> <p>100 kPa to 110 kPa pressure differential</p> <p>Duration of spraying</p>
<p><i>ENDURANCE</i></p> <p>Mechanical</p> <p>High temperature</p> <p>ADDITIONAL ENDURANCE CHARACTERISTICS</p>	<p>9.5</p> <p>9.6</p>	<p>.....operations</p> <p>.....h at..... °C</p>	<p></p>
<p><i>CHEMICAL CONTAMINATION</i></p> <p>Resistance to solvents and contaminating fluids to be used.</p> <p>Applicable fluids.</p> <p>Sulphur dioxide</p>	<p>9.7</p> <p>9.4.8</p>	<p>.....</p> <p>.....</p> <p>.....</p> <p>.....</p> <p>.....</p> <p>.....</p> <p>..... days</p>	<p></p>

(10) Supplementary information

- Marking of the component: in accordance with 11.1 of IEC 61169-1 in the following order of preference:

- 1) Manufacturer code:
 - 2) Manufacturing date code: year/week
 - 3) Component identification: Variant No./ Identification Designation
-

- Marking and contents of package: in accordance with 11.2 of IEC 61169-1

- 1) Information prescribed in 11.1 of IEC 61169-1 detailed above
- 2) Nominal characteristic impedanceΩ.....
- 3) Assessment level code letter
- 4) Any additional marking required

Ordering information

- 1) Number of the detail specification IEC 61169-39...../Variant code..
- 2) Assessment level code letter
- 3) Body finish (if more than one listed)
- 4) Any additional information or special requirements

- Related documents (if not included in IEC 61169-1 or sectional specification):

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- Structural similarity in accordance with 10.2.2 of IEC 61169-1

Bibliography

IEC 62037, *RF connectors, connector cable assemblies and cables – Intermodulation level measurement*

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